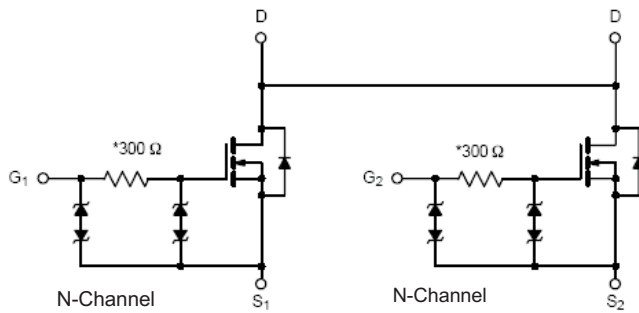


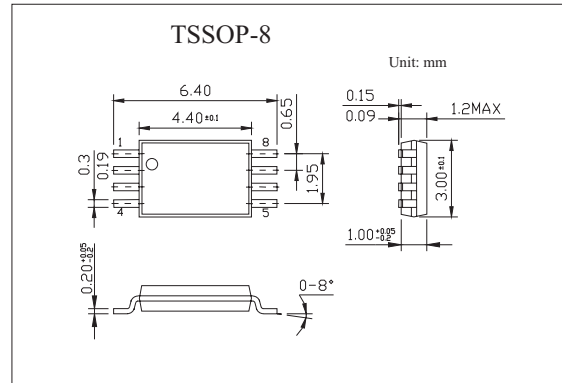
## Dual N-Channel 2.5-V (G-S) MOSFET Common Drain, ESD Protection KI6968BEDQ(SI6968BEDQ)

### ■ Features

- $V_{DS}=20V, r_{DS(on)}=0.022\ \Omega$  @  $V_{GS}=4.5V, I_D=6.5A$
- $V_{BS}=20V, r_{DS(on)}=0.030\ \Omega$  @  $V_{GS}=2.5V, I_D=5.5A$



\* Typical value by design



### ■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter		Symbol	10 secs	Steady State	Unit
Drain-Source Voltage		$V_{DS}$	20		V
Gate-Source Voltage		$V_{GS}$	$\pm 12$		
Continuous Drain Current*	$T_A = 25^\circ\text{C}$	$I_D$	6.5	5.2	A
	$T_A = 70^\circ\text{C}$		5.5	3.5	
Pulsed Drain Current		$I_{DM}$	30		
Continuous Source Current *		$I_S$	1.5	1.0	W
Maximum Power Dissipation	$T_A = 25^\circ\text{C}$	$P_D$	1.5	1.0	
	$T_A = 70^\circ\text{C}$		0.96	0.64	
Operating Junction and Storage Temperature Range		$T_J, T_{stg}$	-55 to 150		$^\circ\text{C}$
Parameter		Symbol	Typ	Max	Unit
Maximum Junction-to-Ambient*	$t \leq 10\ \text{sec}$	$R_{thJA}$	72	83	$^\circ\text{C/W}$
	Steady-State		100	120	
Maximum Junction-to-Foot (Drain)	Steady-State	$R_{thJF}$	55	70	

\* Surface Mounted on FR4 Board,  $t \leq 10\ \text{sec}$ .

**KI6968BEDQ(SI6968BEDQ)**

## ■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	0.6		1.6	V
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 4.5 V			±200	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 16 V, V <sub>GS</sub> = 0 V			1	μ A
		V <sub>DS</sub> = 16 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70°C			25	μ A
On-State Drain Current*	I <sub>D(on)</sub>	V <sub>DS</sub> ≤ 5 V, V <sub>GS</sub> = 4.5 V	30			A
Drain-Source On-State Resistance	r <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 6.5 A		0.0165	0.022	Ω
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 5.5 A		0.023	0.030	Ω
Forward Transconductance*	g <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 6.5 A		30		S
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 10V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 6.5A		12	18	nC
Gate-Source Charge	Q <sub>gs</sub>			2.2		nC
Gate-Drain Charge	Q <sub>gd</sub>			3.6		nC
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, R <sub>L</sub> = 10 Ω I <sub>D</sub> = 1 A, V <sub>GEN</sub> = 4.5V, R <sub>G</sub> = 6 Ω		245	365	ns
Rise Time	t <sub>r</sub>			330	495	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			860	1300	ns
Fall Time	t <sub>f</sub>			510	765	ns
Schottky Diode Forward Voltage*	V <sub>SD</sub>	I <sub>S</sub> = 1.5 A, V <sub>GS</sub> = 0 V		0.71	1.2	V

\* Pulse test; pulse width ≤300 μ s, duty cycle ≤2%.